

# 2.5 V/3.3 V PECL/ECL 1:2 Fanout Buffer

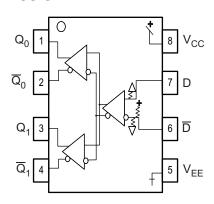
#### **FEATURES**

- 1:2 PECL/ECL Fanout Buffer
- Operating Range
  - PECL:  $V_{CC}$  = 2.375 V to 3.8V With  $V_{EE}$  = 0 V
  - NECL: V<sub>CC</sub> = 0 V With V<sub>EE</sub> = -2.375V to -3.8 V
- Open Input Default State
- Support for Clock Frequencies > 3.0 GHz
- 240 ps Typical Propagation Delay
- Deterministic Output Value for Open Input Conditions
- Q Output Will Default Low When Input Open or at V<sub>EE</sub>
- Built-in Temperature Compensation
- Drop in Compatible to MC10LVEP11, MC100LVEP11
- LVDS Input Compatible

#### **DESCRIPTION**

The SN65LVEP11 is a differential 1:2 PECL/ECL fanout buffer. The device includes circuitry to maintain known logic levels when the inputs are in an open condition. Single-ended clock input operation is limited to  $V_{CC} \geq 3$  V in PECL mode, or  $V_{EE} \leq 3$  V in NECL mode. The device is housed in an industry-standard SOIC-8 package and is also available in TSSOP-8 package option.

#### **PINOUT ASSIGNMENT**



**Table 1. PIN DESCRIPTION** 

PIN	FUNCTION
D, $\overline{D}$	PECL/ECL data inputs
$Q_0, \overline{Q}_0, Q_1, \overline{Q}_1$	PECL/ECL outputs
V <sub>CC</sub>	Positive supply
V <sub>EE</sub>	Negative supply

#### ORDERING INFORMATION(1)

PART NUMBER	PART MARKING	PACKAGE	LEAD FINISH
SN65LVEP11D	SN65LVEP11	SOIC	NiPdAu
SN65LVEP11DGK	SN65LVEP11	SOIC-TSSOP	NiPdAu

(1) Leaded device option not initially available; contact TI sales representative for further information.



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

# **ABSOLUTE MAXIMUM RATINGS**

PARAMETER	CONDITION	VALUE	UNIT
Absolute PECL mode supply voltage VCC	V <sub>EE</sub> = 0 V	6	V
Absolute NECL mode supply voltage, V <sub>EE</sub>	V <sub>CC</sub> = 0 V	-6	V
PECL mode input voltage	6	V	
NECL mode input voltage	-6	V	
Output ourrant	Continuous	50	mA
Output current	Surge	100	mA
Operating temperature range		-40 to 85	°C
Storage temperature range	-65 to 150	°C	

## **POWER DISSIPATION RATINGS**

PACKAGE	CIRCUIT BOARD MODEL	POWER RATING T <sub>A</sub> < 25°C (mW)	THERMAL RESISTANCE, JUNCTION TO AMBIENT NO AIRFLOW	DERATING FACTOR T <sub>A</sub> > 25°C (mW/°C)	POWER RATING T <sub>A</sub> = 85°C (mW)
SOIC	Low-K	719	139	7	288
SOIC	High-K	840	119	8	336
COIC TCCOD	Low-K	469	213	5	188
SOIC-TSSOP	High-K	527	189	5	211

## THERMAL CHARACTERISTICS

	PARAMETER	PACKAGE	VALUE	UNIT
0	Junction-to Board Thermal Resistance	SOIC	79	°C/W
$\theta_{JB}$	Junction-to Board Thermal Resistance	SOIC-TSSOP	120	
0	lunction to Coop Thermal Decistance	SOIC	98	°C/W
$\theta_{\sf JC}$	Junction-to Case Thermal Resistance	SOIC-TSSOP	74	

## **KEY ATTRIBUTES**

CHARACTERISTICS	VALUE
Internal input pull down resistor	75 kΩ
Internal input pull up resistor	37.5 kΩ
Moisture sensitivity level	Level 1
Flammability rating (Oxygen Index: 28 to 34)	UL 94 V-0 at 0.125 in
ESD-HBM	4 kV
ESD-machine model	200 V
ESD-charged device model	2 kV
Meets or exceeds JEDEC Spec EIA/JESD78 latchup test	

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## PECL DC CHARACTERISTICS<sup>(1)</sup> ( $V_{CC} = 2.5 \text{ V}$ ; $V_{EE} = 0.0 \text{ V}$ )<sup>(2)</sup>

	DADAMETED		-40°C			25°C		85°C			UNIT
	PARAMETER	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNII
I <sub>CC</sub>	Power supply current		28	45		31	45		35	45	mA
V <sub>OH</sub>	Output HIGH voltage (3)	1355		1605	1355	1425	1605	1335		1605	mV
V <sub>OL</sub>	Output LOW voltage (3)	555		900	555	759	900	555		900	mV
$V_{IH}$	Input high voltage (Single-Ended)	1335		1620	1335		1620	1335		1620	mV
V <sub>IL</sub>	Input low voltage (Single-Ended)	555		900	555		900	555		900	mV
V <sub>IHCMR</sub>	Input HIGH voltage common mode range (Differential) <sup>(4)</sup>	1.2		2.5	1.2		2.5	1.2		2.5	V
I <sub>IH</sub>	Input HIGH current			150			150			150	μΑ
I <sub>IL</sub>	Input LOW current (D)	0.5			0.5			0.5			
	nput LOW current (-D)	-150			-150			-150			μΑ

The device will meet the specifications after the thermal balance has been established when mounted in a socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are assured only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- Input and output parameters vary 1:1 with  $V_{CC}$ .  $V_{EE}$  can vary +0.125 V to 1.3 V. All loading with 50  $\Omega$  to  $V_{CC}$  -2 V.  $V_{IHCMR\ min}$  varies 1:1 with  $V_{EE}$ ,  $V_{IHCMR\ max}$  varies 1:1 with  $V_{CC}$ . The  $V_{IHCMR\ range}$  is referenced to the most positive side of the differential input signal. Single ended input clock pin operation is limited to  $V_{CC} \ge 3.0$  V in PECL mode.

# PECL DC CHARACTERISTICS<sup>(1)</sup> (V<sub>CC</sub> = 3.3 V; V<sub>EE</sub> = 0.0 V)<sup>(2)</sup>

		-40°C				25°C			85°C		
	PARAMETER	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
I <sub>CC</sub>	Power supply current		28	45		32	45		36	45	mA
V <sub>OH</sub>	Output HIGH voltage (3)	2155		2405	2155	2221	2405	2155		2405	mV
V <sub>OL</sub>	Output LOW voltage <sup>(3)</sup>	1355		1700	1355	1543	1700	1355		1700	mV
V <sub>IH</sub>	Input high voltage (Single-Ended) (4)	2135		2420	2135		2420	2135		2420	mV
V <sub>IL</sub>	Input low voltage (Single-Ended) (4)	1355		1700	1355		1700	1355		1700	mV
V <sub>IHCMR</sub>	Input HIGH voltage common mode range (Differential) <sup>(5)</sup>	1.2		3.3	1.2		3.3	1.2		3.3	V
I <sub>IH</sub>	Input HIGH current			150			150			150	μΑ
I <sub>IL</sub>	Input LOW current (D)	0.5			0.5			0.5			^
	nput LOW current (-D)	-150			-150			-150			μΑ

<sup>(1)</sup> The device will meet the specifications after the thermal balance has been established when mounted in a socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are specified only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously

- Input and output parameters vary 1:1 with  $V_{CC}$ .  $V_{EE}$  can vary +0.925 V to -0.5 V.
- All loading with 50  $\Omega$  to  $V_{CC}$  2 V.
- Single Ended input clock pin operation is limited to VCC ≥ 3 V in PECL mode.
- V<sub>IHCMR min</sub> varies 1:1 with V<sub>EE</sub>, V<sub>IHCMR max</sub> varies 1:1 with V<sub>CC</sub>. The V<sub>IHCMR</sub> range is referenced to the most positive side of the differential input signal.

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# NECL DC CHARACTERISTICS<sup>(1)</sup> ( $V_{CC} = 0.0 \text{ V}$ ; $V_{EE} = -3.8 \text{V}$ to -2.375 V)<sup>(2)</sup>

	DADAMETED		–40°C			25°C			85°C		UNIT
	PARAMETER	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNII
I <sub>CC</sub>	Power supply current		28	45		32	45		36	45	mA
V <sub>OH</sub>	Output HIGH voltage (3)	-1145		-895	-1145	-1065	-895	-1145		-895	mV
V <sub>OL</sub>	Output LOW voltage <sup>(3)</sup>	-1945		-1600	-1945	-1777	-1600	-1945		-1600	mV
V <sub>IH</sub>	Input high voltage (Single-Ended) <sup>(4)</sup>	-1165		-880	-1165		-880	-1165		-880	mV
V <sub>IL</sub>	Input low voltage (Single-Ended) <sup>(4)</sup>	-1945		-1600	-1945		-1600	-1945		-1600	mV
V <sub>IHCM</sub>	Input HIGH voltage common mode range (Differential) (5)	V <sub>EE</sub> +1.2	V <sub>EE</sub> +1.2	0.0	V <sub>EE</sub> +1.2	V <sub>EE</sub> +1.2	0.0	V <sub>EE</sub> +1.2	V <sub>EE</sub> +1.2	0.0	V
I <sub>IH</sub>	Input HIGH current			150			150			150	μΑ
I <sub>IL</sub>	Input LOW current (D)	0.5			0.5			0.5			
	nput LOW current (-D)	-150			-150			-150			μΑ

- The device will meet the specifications after thermal balance has been established when mounted in a socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are assured only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously
- Input and output parameters vary 1:1 with V<sub>CC</sub>.
- All loading with 50  $\Omega$  to  $V_{CC}$  2  $\dot{V}$ .
- Single Ended input clock pin operation is limited to VCC  $\leq$  -3 V in NECL mode.  $V_{IHCMR\ min}$  varies 1:1 with  $V_{EE}$ ,  $V_{IHCMR\ max}$  varies 1:1 with  $V_{CC}$ . The  $V_{IHCMR}$  range is referenced to the most positive side of the differential input signal.

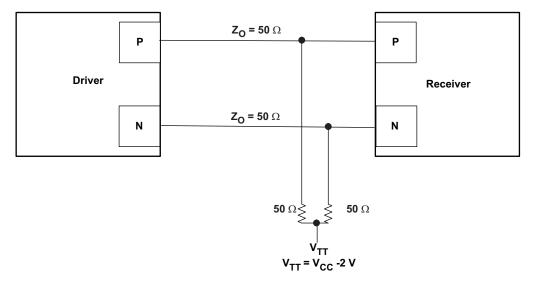
# AC CHARACTERISTICS<sup>(1)</sup> ( $V_{CC}$ = 2.375 V to 3.8 V; $V_{EE}$ = 0.0 V or $V_{CC}$ = 0.0 V; $V_{EE}$ = -3.8 V to -2.375 V<sup>(2)</sup>

	PARAMETER		–40°C			25°C		85°C			UNIT
			TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNII
f <sub>MAX</sub>	Max switching frequency <sup>(3)</sup> (see Figure 6)		3.8			3.5			3.1		GHz
t <sub>PLH</sub> /t <sub>PHL</sub>	Propagation delay to output differential (CLK, Q, -Q)	200		300	200		300	200		300	ps
t <sub>SKEW</sub> Device skew ( Q, -Q)			8			8	15		8	15	ps
	Device to Device Skew (Q, -Q) (4)			25			25			25	
t <sub>JITTER</sub>	Random clock jitter (RMS) ≤ 1.0 GHz			0.3			0.3			0.3	ps
	Random Clock Jitter (RMS) ≤ 1.5 GHz			0.2			0.2			0.2	
	Random Clock Jitter (RMS) ≤ 2.0 GHz			0.2			0.2			0.2	
Random Clock Jitter (RMS) ≤ 2.5 GHz				0.2			0.2			0.2	
	Random Clock Jitter (RMS) ≤ 3.0 GHz			0.2			0.2			0.2	
V <sub>PP</sub>	Input swing Differential Config.	150	800	1200	150		1200	150		1200	mV
t <sub>r</sub> /t <sub>f</sub>	Output rise/fall times Q, -Q (20%-80%)	100		200	100		200	100		200	ps

- The device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are assured only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.
- Measured using a 750 mV source, 50% duty cycle clock source. All loading with 50  $\Omega$  to V<sub>CC</sub> -2 V.
- The maximum switching frequency measured at the output amplitude of 300 mVpp.
- Skew is measured between outputs under identical transitions



## **Typical Termination for Output Driver**



**Figure 1. Typical Termination for Output Driver** 

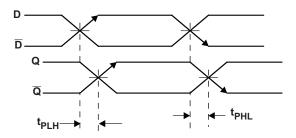


Figure 2. Propagation Delay

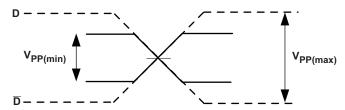


Figure 3. Input Voltage Swing

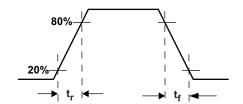


Figure 4. Output Rise and Fall Times

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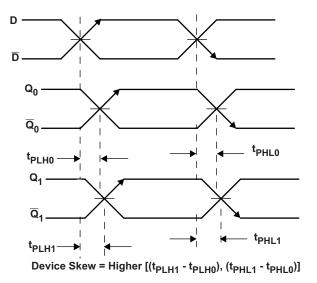


Figure 5. Device Skew

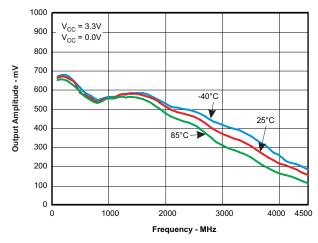


Figure 6. Output Amplitude vs Frequency





10-Dec-2020

#### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
SN65LVEP11D	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVEP11	Samples
SN65LVEP11DGK	ACTIVE	VSSOP	DGK	8	80	RoHS & Green	Call TI   NIPDAU	Level-1-260C-UNLIM	-40 to 85	SIJI	Samples
SN65LVEP11DGKR	ACTIVE	VSSOP	DGK	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	SIJI	Samples
SN65LVEP11DR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVEP11	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

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Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## PACKAGE OPTION ADDENDUM

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# **PACKAGE MATERIALS INFORMATION**

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## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

D	evice	U	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN65LV	EP11DGKR	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
SN65L	VEP11DR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

# **PACKAGE MATERIALS INFORMATION**

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### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN65LVEP11DGKR	VSSOP	DGK	8	2500	356.0	356.0	35.0
SN65LVEP11DR	SOIC	D	8	2500	356.0	356.0	35.0

# **PACKAGE MATERIALS INFORMATION**

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## **TUBE**



\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN65LVEP11D	D	SOIC	8	75	506.6	8	3940	4.32
SN65LVEP11DGK	DGK	VSSOP	8	80	330.2	6.6	3005	1.88



SMALL OUTLINE PACKAGE



#### NOTES:

PowerPAD is a trademark of Texas Instruments.

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
- 9. Size of metal pad may vary due to creepage requirement.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 12. Board assembly site may have different recommendations for stencil design.





SMALL OUTLINE INTEGRATED CIRCUIT



## NOTES:

- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



#### NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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